TOSHIBA Transistor Silicon NPN Epitaxial Type

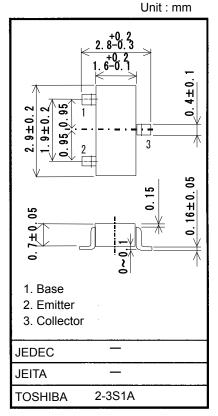
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High-Speed Swtching Applications DC-DC Converter Applications Storobe Flash Applications

- High DC current gain: $h_{FE} = 250$ to 400 (IC = 0.3 A)
- Low collector-emitter saturation: $V_{CE (sat)} = 0.18 \text{ V (max)}$
- High-speed switching: tf = 38 ns (typ.)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		V_{CBO}	100	V	
Collector-emitter voltage		V _{CEX}	80	V	
		V _{CEO}	50	٧	
Emitter-base voltage		V _{EBO}	6	V	
Collector current	DC	Ic	2.5	Α	
	Pulse	I _{CP}	5		
Base current		ΙΒ	0.3	Α	
Collector power dissipation	t = 10s	Dr. (Noto 1)	1.00	W	
	DC	P _C (Note 1)	0.625		
Junction temperature		Tj	150	°C	
Storage temperature range		T _{stg}	–55 to 150	°C	



Weight: 0.01g (Typ.)

- Note 1: Mounted on an FR4 board (glass epoxy, 1.6mm thick, Cu area: 64.5 mm²)
- Note 2: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current		I _{CBO}	V _{CB} = 100 V, I _E = 0	_	_	0.1	μΑ
Emitter cut-off current		I _{EBO}	V _{EB} = 6 V, I _C = 0	_	_	0.1	μΑ
Collector-emitter breakdown voltage		V (BR) CEO	$I_C = 10 \text{ mA}, I_B = 0$	50	_	_	V
DC current gain		h _{FE} (1)	$V_{CE} = 2 \text{ V}, I_{C} = 0.3 \text{ A}$	250	_	400	
		h _{FE} (2)	V _{CE} = 2 V, I _C = 1.0 A	120	_	_	
Collector-emitter sa	turation voltage	V _{CE} (sat)	I _C = 1.0 A, I _B = 33 mA	_	_	0.18	V
Base-emitter saturation voltage		V _{BE} (sat)	I _C = 1.0 A, I _B = 33 mA	_	_	1.10	V
Collector output capacitance		C _{ob}	V _{CB} = 10 V, I _E = 0, f = 1MHz	_	18	_	pF
Switching time	Rise time	t _r	See Figure 1. $V_{CC} \simeq 20 \text{ V, R}_L = 20 \Omega$ $I_{B1} = -I_{B2} = 33 \text{ mA}$	_	25	_	ns
	Storage time	t _{stg}		_	470	_	
	Fall time	t _f		_	38	_	

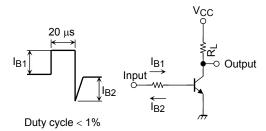
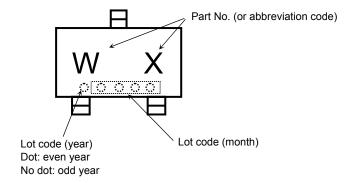
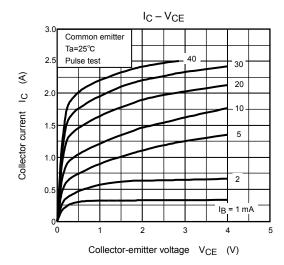
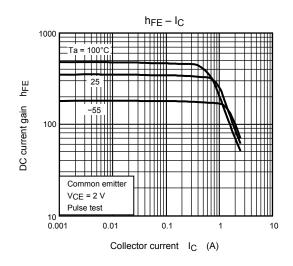


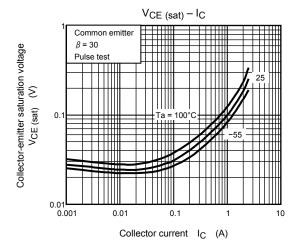
Figure 1 Switching Time Test Circuit & Timing Chart

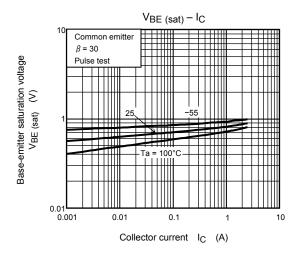
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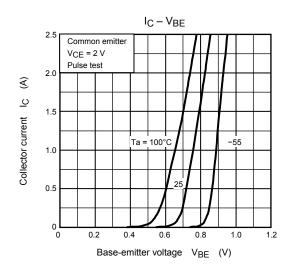




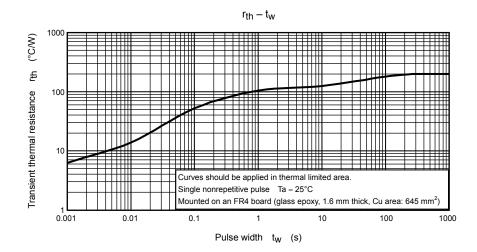


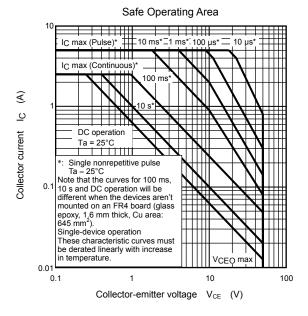






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